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On-o Interm ittency in Stochastically D riven E lectrohydrodynam ic C onvection in N em atics

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We report on-o interm ittency in electroconvection of nem atic liquid crystals driven by a dichotom ous stochastic electric voltage. With increasing voltage amplitude we observe laminar phases of undistorted director state interrupted by shorter bursts of spatially regular stripes. Near a critical value of the amplitude the distribution of the duration of laminar phases is governed over several decades by a power law with exponent 3=2. The experimental notings agree with simulations of the linearized electrohydrodynam ic equations near the sam ple stability threshold.

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System s at a threshold of stability driven by a stochastic or chaotic process coupling multiplicatively to the system variablesm ay exhibit on-o intermittency characterized by specic statistical properties of the interm ittent signal. Quiescent (or lam inar) periods (o -states) are interrupted by bursts of large variation (on-states); the duration of lam inar periods is governed by power laws with exponents universal over a broad class of di erent system s. Early theoretical studies considered system s with few degrees of freedom modeled by di erential equations [1] and m appings [2]. There is increasing interest in system swith m any degrees of freedom $[\beta]$, described by random map lattices [4], larger system s of coupled nonlinear elements [5], and partial di erential equations [5,6]. Experim ental results are available mainly for nonlinear electric circuits [7]; on-o interm ittency was also observed in a spin wave experiment [8], in optical feedback [9], and a gas discharge plasm a system [10]. Here we rst report about on-o intermittency in a spatially extended dissipative system, viz. electroconvection (EC) in nem atic liquid crystals driven by a stochastic voltage.

EC in planarly aligned nem atics is a standard system for pattern form ation, for recent reviews see, e.g. [11]. In the presence of an electric eld E a spontaneous uctuation of the director leads due to the anisotropic conductivity to a form ation of space charges which tend to destabilize the hom ogeneously ordered state. W ith increasing strength of the driving eld one observes a hierarchy of convection patterns of increasing com plexity. The patterns depend on external param eters such as am plitude, frequency and wave form of the driving voltage which are conveniently adjustable in the experim ent. The hydrodynam ic ow induces a modulation of the director eld and thus of the elective indices of refraction which leads to transm ission patterns easily observed with a microscope.

In previous experiments, the superposition of a deterministic AC eld with a stochastic eld, $E = E^{det}(t) + E^{stoch}(t)$, was studied. A variety of noise induced phenomena including stabilization or destabilization of the hom ogeneous state, and a change from continuous to discontinuous behaviour of the threshold as a function of the noise strength was observed [12{16] and has stimulated theoretical work [17,18].

As long as the characteristic time of the noise stoch is sm all compared with characteristic times of the system the threshold towards pattern form ation appears sharp as for determ inistic driving. It is how ever typical for EC in nem atics that one of the system s characteristic times decreases both with increasing strength of the threshold voltage and with increasing wave number of the pattern and may reach the order of stoch [18]. In this case, one observes interm ittent bursts of a regular spatial stripe pattern which makes a na ve experim ental determ ination of the stochastic threshold di cult [16]. A sim ilar phenom enon was noticed in a highly doped nem atic material for very high strength of the noise [13] where a direct transition towards chaos occurs via interm ittent bursts of spatially incoherent structures embedded in a hom ogeneous background.

In this paper, we consider the simplest case of pure stochastic excitation, $E = E^{\text{stoch}}(t)$. To achieve a statistical characterization we have determ ined experimentally the distribution of the duration of laminar, i.e. undistorted phases (o -states) which are interrupted by bursts of a stripe pattern (on-states). Approaching a critical voltage from below, this distribution is governed by a power law $3^{=2}$ over several orders of as it is typical for on-o -interm ittency. This result is con med by sim – ulations of the linearized electrohydrodynam ic equations at the sample stability threshold [18].

W e use the standard experimental set-up with a commercial cell (Linkam) providing planar anchoring of the director by antiparallely nubbed polyimide coatings, two transparent ITO electrodes of 5 5m m² and a cell gap of d = 50 m. The nematic material is a mixture of four disubstituted phenylbenzoates [16] which has a nematic range from below room temperature to 70.5 C. The cell temperature is controlled at 30 C by a Linkam heating stage. In ages are recorded using a Jenapol-d polarizing m icroscope and a Ham am atsu B/W cam era with controller C 2400. The transm ission in ages of light polarized along the director easy axis n_0 are recorded digitally. We resolve the images in 500 400 (330 250) pixels with 8 bits greyscale and calculate standard deviations in real time at a rate of 1/7 (1/20) s in the conductive (dielectric) regime.

As driving process we use the dichotom ous M arkov process (DMP) which is easily generated and faciliates the theoretical analysis. The DMP E_t^{DMP} jumps random ly between E with average rate . The distribution of times ~ between two consecutive jumps is exp (~); the autocorrelation decays exponentially, < $E_t^{DMP}E_t^{DMP} >= E^2 \exp[2 (t t^0)]$, i.e. $_{stoch} = 1=2$. We will refer to = =2 as the mean frequency and to E as the am plitude of the noise. Both in experiment and simulation, sequences of the DMP are generated by the same a algorithm; technically ~ is limited to vary between 10⁴ s and 10⁴ s.

For excitation by a periodic square wave, one nds a typical frequency dependent threshold voltage U_c (U = E d) for the stability against formation of normal rolls, cf. Fig. 1. There is a sharp transition at $_c = 38 \text{ Hz}$ between the conductive regime (oscillating space charges) characterized by a wavenum ber $k_x = d$ and the dielectric regime (oscillating director de ections), where k_x is an order of magnitude larger, cf. Fig. 1.



FIG.1. Threshold voltages and wave numbers for driving with periodic and stochastic square waves of (m ean) frequency . Experimental data (diamonds: periodic case; circles, triangles, and full squares: stochastic case, see text; dashed lines guide the eyes) are compared with results from the two-dimensional theory (full line: periodic case; dotted line: stochastic case).

For stochastic driving, we have observed bursts of stripe pattern uniform across the system already below the onset threshold for a periodic voltage of the sam e frequency. The stochastic voltage has a broad frequency spectrum which contains low frequency contributions. O ccasional bursts of convective pattern can be expected at voltages above the DC threshold (= 0 in Fig. 1a). W ith increasing voltage the frequency of the bursts increases. In Fig. 1a we have plotted the voltages which correspond to a ratio of 75% (circles) and 25% (triangles) of lam inar phases, respectively. The full squares at = 60 H z and 180 H z indicate the voltages for which the experim entally determ ined distribution of lam inar periods is best described by a $^{3=2}$ law (see below). The theoretical results obtained from the sam ple stability criterion explained below agree very well with the experim ental data. (B oth in the periodic and the stochastic case we have used the sam e m aterial param eters.)



FIG.2. Snapshots of the bursts of roll patterns (a, b) in the conductive regime (= 60 Hz, $k_x = 12 \ 10^3$ cm⁻¹, area size 200 164 m⁻²) and (c, d) in the dielectric regime (= 180 Hz, $k_x = 7.2 \ 10^3$ cm⁻¹, area size 134 102 m⁻²) at di erent times. (a, c) show the patterns just at the threshold of the on-state ($_{rel} = 0.1$) whereas in (b, d) the rolls are fully developed ($_{rel} = 0.8$).

The set of images in Fig. 2 shows the stripe pattern at dierent times of a burst just at the threshold of the on-state and the fully developed pattern in both the dielectric and the conductive regime. We characterize the intensity modulation of these patterns by ₀)=(1 0) where is the normalized stan- $_{rel} = ($ dard deviation from the average intensities taken over all pixels of the image at a given instant, and $_0$ is the value of for zero voltage. This procedure allows a real time characterization of the patterns. It is justiled since the largest Fourier coe cient dom inates the intensity modulation, and both quantities have nearly equivalent traces. A lthough the relation between rel and the director deections is nonlinear, the approach used here is su cient if we are interested only in the frequency and duration of the bursts and not prim arily in their am plitudes.

In Fig. 3 we present trajectories of $_{rel}(t)$ observed in the experiment for dierent noise amplitudes but the same seed of the driving DMP. As laminar phase we de ne the period in which $_{rel}(t)$ is below a threshold $_{lam} = 0.1$ where the choice of $_{lam}$ is not crucial. The laminar periods are interrupted by bursts of the convection structures, the frequency of which increases with the applied voltage amplitude U.

In Figs. 4 and 5 we compare the experimentally determ ined distributions p() for the occurence of lam inar phases of duration with those obtained in simulations in the conductive and the dielectric regime, respectively.



FIG.3. Bursts of the intensity modulation $_{rel}(t)$ in the conductive regime (a) just at the threshold and (b) 0.3 V above threshold for identical trajectories of the DMP which makes about 9 10^4 jumps in the period shown (= 60 Hz). The dashed lines indicate $_{lam}$ above which the system is in the on-state and else in the o-state.



FIG.4. Normalized distribution p() in the conductive regime (= 60 Hz) just at the stability threshold and slightly above. Shown are results (a) from experiment for U = 14.6 V (squares) and 15.3 V (triangles), and (b) from simulations for U = $U_c = 18.2$ V (full line) and U = 19.0 V (dashed line). M ode selection gives a wave number $k_x = 1484$ cm⁻¹ used in the simulation. The dash-dotted lines indicate a power law $^{3=2}$.



FIG.5. Normalized distribution p() in the dielectric regime (= 180 Hz) slightly below U_c, just at U_c, and slightly above. Shown are (a) experimental results for U = 76.0 V (circles), 79.5 V (squares), and 83.0 V (triangles), and (b) simulations for U = 82.0 V (dotted line), U = U_c = 84.9 V (full line), and U = 90.0 V (dashed line). Mode selection gives $k_x = 7670$ cm⁻¹ used in the simulation. D ash-dotted line as in Fig. 4.

The experimental histograms contain data from about 2500 bursts of rel (t) recorded over 1 ::: 6 h. W ith increasing voltage am plitude the frequency of bursts increases, i.e. longer lam inar periods occur less frequently. At a critical voltage U_c (full squares in Fig. 1a) the distribution is governed by a power law p ³⁼² over several decades. Deviations occur for very small due to the nite time resolution and for very large due to the background uctuations from therm al noise. Increasing the amplitude beyond the critical voltage leads to exponential corrections to the power law discussed below . Increasing the voltage further, the system does not reach a state of perm anent convection, instead the patterns becom em ore and m ore spatially irregular w hile keeping its interm ittent character.

The theoretical description of the laminar phases is based on the linearized nem ato-electrohydrodynamic equations. In a two-dim ensional idealization using stress-free boundary conditions, inserting as a test mode a periodic rollpattern characterized by wave num bers k_x and $k_z = -d$ they reduce to the ordinary di erential equations [18]

$$\mathbf{z} = \mathbf{C} \quad (\mathbf{t})\mathbf{z}; \quad \mathbf{z} = \begin{array}{c} \mathbf{q} \\ \mathbf{;} \end{array}$$

where q and $are the amplitudes of the space charge density and of <math>\ell_x'$ (' is the angle between director and electrode plates), and

C (t) =
$$\begin{array}{c} 1 = T_{q} & _{H} E_{t}^{DMP} \\ a E_{t}^{DMP} & _{1} & _{2}E^{2} \end{array}$$
 (2)

The parameters T_{q} , $_{H}$, a, $_{1}$, and $_{2}$ depend on material properties and on the wave number k_{x} which is determined by minim izing the threshold voltage, cf. [18]. Between two consecutive jumps of E_{t}^{DMP} at t and t_{+1} the matrix C (t) is constant, and the time evolution is given by $z(t) = T^{s}$ (t t)z(t) for $t < t < t_{+1}$ where $T^{s}(t)$ is the time evolution matrix for sgnE $_{t}^{DMP} = s$. Iteration gives the form all solution [18] for a given realization of the driving process with jumps at the random timest; = 1; :::;n

$$z(t) = T^{s_n}(t t_n) \qquad {}^{s_0} I(t_1 t_0) z(t_0):$$
 (3)

The threshold voltage U_c for a given wave number is determined by the zero of the largest Lyapunov exponent $_1$ of the product of random matrices in (3) which can be calculated analytically as well as the second Lyapunov exponent $_2 < _1$ at the threshold [18]. Whereas $_{\rm sys;1} = 1 = j_1 j$ diverges at the threshold we found for the examples presented here in the conductive (dielectric) regime $_{\rm sys;2} = 1 = j_2 j = 3.0 \quad 10^{-3} \text{ s} (0.9 \quad 10^{-3} \text{ s})$ which is of the same order as $_{\rm stoch} = 1 = 2 = 4.2 \quad 10^{-3} \text{ s} (1.4 \quad 10^{-3} \text{ s})$.

The numerical simulation generates trajectories z (t) starting from a small nonzero initial value z (t₀), cf. Eq.

(3). To model the background of therm al uctuations of we introduced a lower cuto _{m in}, ie. ! _{m in} sgn for j j < min. In the dielectric regime we additionally reset q in a similar way. A trajectory is considered lam inar as long as j j is sm aller than a given threshold $_{lam} = 2$ 10³ $_{min}$. At U_c the distribution is a power $^{3=2}$ over several orders of with deviations for very law sm all and very large as in the experiment, cf. Figs. 4b and 5b. The range of validity of the power law increases when $m_{in} = l_{am}$ is low ered. A loo for voltages smaller or larger than U_c the shape of the simulated distributions is very similar to that obtained in experiment. The shoulder for large becom es m ore pronounced for voltages below the critical voltage.



FIG.6. (a) Normalized distribution p() in the conductive regime (= 60 Hz) obtained from simulations with very small lower cuto at U_c (full squares), and slightly above: U = 0.05 V (squares) and U = 0.2 V (triangles). The lines indicate the modi ed power law mentioned in the text. (b) shows the mean value of duration of lam in ar periods as function of U.k_x as in Fig. 4.

To distinguish between e ects due to therm al uctuations and due to a deviation from the stability threshold U = U U_c we have also performed simulations with min = 10³⁰⁰ lam (which is obviously too small for comparison with experiment). At U_c the power law holds now over 8 decades. Above threshold the results agree very well with p ³⁼² exp(const U²), see Fig. 6a. The mean duration of lam inar periods behaves like U¹, cf. Fig. 6b. Sim ilar laws have been obtained analytically in [2] for a one-dimensional mapping.

We have found on-o interm ittency in a spatially extended dissipative system driven by multiplicative noise at parameter values where the rst instability is towards spatially regular structures. If the strength of the noise approaches a critical value both experiment and simulations of the electrohydrodynamic equations lead to a power law with exponent 3=2 for the distribution of laminar periods. The simulations show that this critical value is just the threshold of stability according to the sam ple stability criterion [18].

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